

# **An Automatic Calibration System for 10 M $\Omega$ to 1 T $\Omega$ DC Standard Resistors**

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## **Abstract**

At SCL, a simple automatic system is implemented based on a modified Wheatstone bridge. With this system, measurement uncertainty,  $u_c$ , of less than  $10 \times 10^{-6}$  can be achieved for calibrating 10 M $\Omega$  to 1 G $\Omega$  resistors.  $u_c$  for resistance calibration above 1 G $\Omega$  become larger, mainly due to the temperature coefficients of the resistors.

## **1. Introduction**

The system comprises a control software written in Visual Basic and a modified Wheatstone bridge, whose two arms are programmable dc calibrators supplying test voltages at selectable magnitudes (1 V to 1000 V) and ratios (1:1 to 1: 100) to the unknown and reference resistors that form the remaining two bridge arms. To minimise the leakage effect, '3-terminal' configuration is used for resistance connection. A programmable electrometer, Keithley 6517, in current mode with a resolution of 0.1 pA is used to measure the current imbalance (i.e. the difference in currents that flow through the unknown and standard resistors). Parameter setting, instrument control, error handling and real-time monitoring of outcomes are performed via a user-friendly graphical user interface.

## **2. The Resistance Bridge**

At the time of balance, the two programmable voltage sources,  $V_X$  and  $V_S$ , are set to a ratio equal to that of the values of unknown and standard resistors,  $R_X$  and  $R_S$ .

That is  $V_X/V_S = R_X/R_S$ .

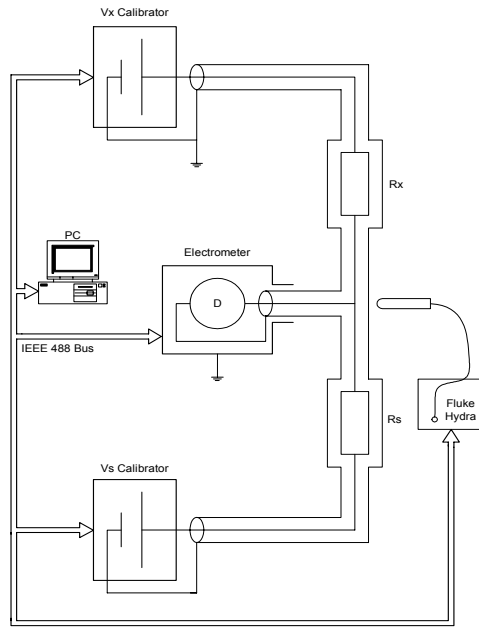


Figure 1: The modified Wheatstone Bridge

To minimise the leakage effect, ‘3-terminal’ configuration is used for connecting resistors to the bridge. As shown in Figure 2, the chassis of the resistors are connected to the Bridge’s earth with this configuration. The leakage paths  $L_2$  and  $L_3$  are placed across the null detector whilst the other two leakage paths  $L_1$  and  $L_4$  are placed across the  $V_X$  and  $V_S$  calibrators. In this configuration, errors caused by  $L_1$  and  $L_4$  are less than  $0.1 \times 10^{-6}$ , as the output resistances of the calibrators,  $V_X$  and  $V_S$ , are so low. Obviously, since the impedance of the electrometer is so low,  $L_2$  and  $L_3$  do not cause any significant errors.

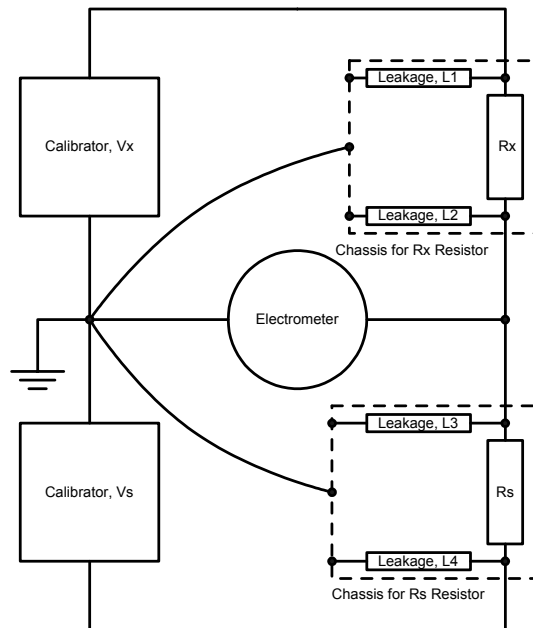


Figure 2: The “3-terminal” configuration

### 3. The Balance Algorithm

Initially, the voltage sources are set to the nominal ratio of  $R_X$  and  $R_S$ . An electrometer with resolution of 0.1 pA in the current mode is used as a null detector to monitor the bridge's balance condition, which is indicated by the imbalance current,  $I_D$ . In fact,  $I_D$  is the difference between the two currents that flow through  $R_X$  and  $R_S$ .

To balance the bridge, the system works out a new output setting for calibrator  $V_S$ , based on the magnitude and direction of  $I_D$ , such that  $V_S' = V_S - I_D \times R_S$ . The system will then check if the bridge has reached the null condition that is acceptable by the operator.

If  $(|V_S' - V_S| \div V_S) < B^*$ , the bridge is considered as its null condition. Otherwise,  $V_S$  will be set to the new value  $V_S'$  and the above process will be repeated until the bridge is balanced. (Note \*:  $B$  is a system parameter selected by the operator.)

### 4. Errors in the Resistance Bridge

The calibrator outputs ( $V_X$  and  $V_S$ ) can be expressed as follows:

$$V_{output} = V_{setting} \times Gain + V_{offset}$$

The offset and gain errors in the voltage sources,  $V_X$  and  $V_S$ , will cause discrepancy between  $V_{output}$  and  $V_{setting}$ . This discrepancy will eventually give rise to errors in the resistance bridge and measurement results.

#### 4.1 Offset Errors

When both  $V_X$  and  $V_S$  are set to zero, the current that flows through the electrometer is essentially due to the zero offsets of the calibrators (i.e.  $V_{X\_OFFSET}$  and  $V_{S\_OFFSET}$ ). This will appear as the bridge's offset current,  $I_O$ .

$$I_o = \frac{V_{X\_OFFSET}}{R_X} + \frac{V_{S\_OFFSET}}{R_S}$$

To minimize the offset error, before a measurement is commenced, the system sets  $V_X$  and  $V_S$  to zero. Then, it activates the electrometer's zero function to eliminate the zero offsets. This is to make sure that the offset current is not included in the imbalance current,  $I_D$ . That is:  
 $I_D = I - I_O$

## 4.2 Gain Errors

Although the calibrator gains,  $G_X$  and  $G_S$ , are equal to one nominally, it is expected that there will be errors in the calibrator gains.

That is,  $G_X = 1 + \delta G_X$  and  $G_S = 1 + \delta G_S$ . It is expected that  $\delta G_X \neq \delta G_S \neq 0$ .

Hence, when the bridge is at balance, the apparent ratio  $R_X$  and  $R_S$  is:  $\frac{R_X}{R_S} = -\frac{V_{X\_SETTING}}{V_{S\_SETTING}}$

However, due to gain errors, the actually relationship for  $R_X$  and  $R_S$  is:

$$\frac{R_X}{R_S} = -\frac{V_{X\_SETTING}(1 + \delta G_X)}{V_{S\_SETTING}(1 + \delta G_S)}$$

The system will apply a Ratio Correction Factor ( $RCF$ ) to the apparent  $R_X : R_S$  ratio in order to correct the gain errors. The reported value for  $R_X$  will be as follows:

$$R_X = RCF \times R_S \times -\frac{V_{X\_SETTING}}{V_{S\_SETTING}}$$

where

$$RCF = \frac{1 + \delta G_X}{1 + \delta G_S}$$

The  $RCF$  is a operational parameter, which should be determined beforehand and is imported to the system before the measurement commences.

## 5. System Performance

### 5.1 1:1 Ratio

To check the bridge's performance at 1:1 ratio, two standard resistors,  $R_1$  and  $R_2$ , with nominally equal resistance were used. The bridge's 1:1 ratio error,  $\varepsilon$ , was determined by:

$$\varepsilon = \sqrt{X \times Y} - 1$$

where  $X$  and  $Y$  are the resistance ratios measured by the bridge, such that :

$$X = \varepsilon \cdot \frac{R_1}{R_2} \text{ and } Y = \varepsilon \cdot \frac{R_2}{R_1}$$

The bridge's 1:1 ratio error,  $\varepsilon$ , at test voltages of 10 V, 100 V and 1000 V are:

Test Voltages	Resistance Ratio	Ratio Error, $\varepsilon$
10 V and 100 V	10 M $\Omega$ : 10 M $\Omega$	$\leq 0.5 \times 10^{-6}$
10 V and 100 V	100 M $\Omega$ : 100 M $\Omega$	$\leq 0.5 \times 10^{-6}$
10 V, 100 V and 1 kV	1 G $\Omega$ : 1 G $\Omega$	$\leq 1.5 \times 10^{-6}$
10 V, 100 V and 1 kV	10 G $\Omega$ : 10 G $\Omega$	$\leq 5 \times 10^{-6}$
10 V, 100 V and 1 kV	100 G $\Omega$ : 100 G $\Omega$	$\leq 6 \times 10^{-6}$

## 5.2 10:1 and 100:1 Ratios

To check the system's performance at these ratios, test resistors were measured by this automatic bridge and the results obtained were compared with those obtained by a manual bridge. The results are agreed within  $2 \times 10^{-6}$  for 1 G $\Omega$  and below and within  $10 \times 10^{-6}$  for test resistors higher than 1 G $\Omega$ .

## 6. Estimated Standard Measurement Uncertainty

Uncertainty Contribution	Test Resistor			
	$\leq 1$ G $\Omega$	10 G $\Omega$	100 G $\Omega$	1 T $\Omega$
Reference Resistor	$2 \times 10^{-6}$	$5 \times 10^{-6}$	$30 \times 10^{-6}$	$160 \times 10^{-6}$
Voltage Sources	$2 \times 10^{-6}$	$2 \times 10^{-6}$	$2 \times 10^{-6}$	$2 \times 10^{-6}$
Null Uncertainty	$0.12 \times 10^{-6}$	$0.58 \times 10^{-6}$	$1 \times 10^{-6}$	$3 \times 10^{-6}$
Temperature Effect	$1 \times 10^{-6}$	$15 \times 10^{-6}$	$150 \times 10^{-6}$	$1500 \times 10^{-6}$
Random (Noise) Effect	$0.2 \times 10^{-6}$	$2 \times 10^{-6}$	$3 \times 10^{-6}$	$10 \times 10^{-6}$
Combined Std. Uncertainty	$2 \times 10^{-6}$	$29 \times 10^{-6}$	$160 \times 10^{-6}$	$1500 \times 10^{-6}$

## 7. Conclusion

An automatic modified Wheatstone bridge has been implemented for calibration DC standard resistors from 10 M $\Omega$  to 1 T $\Omega$ .

## 8. Reference

- [1] L.C.A. Henderson, "A New Technique for the Automatic Measurement of High Value Resistors". Journal of Phys., Electron. Sci. Instrum., Vol. 20. pp. 492-495, Sep. 1987.
- [2] D.G. Jarrett, "Automated Guard Bridge for Calibration of Multimegohm Standard Resistors", IEEE Trans. Inst. Meas., Vol. 46, No. 2, Apr. 1997.